

BIPOLAR ANALOG INTEGRATED CIRCUIT μ PC29S00 Series

LOW DROPOUT VOLTAGE REGULATOR WITH ON/OFF FUNCTION

The μ PC29S00 series is a low dropout regulator which has 100 mA capable for the output current. This series features ON/OFF function to control output voltage.

The μ PC29S00 series is suitable for NEC's single chip microcontroller which have on-chip flash memory. The μ PC29S00 series is use of erasing and writing data on its flash memory.

FEATURES

- ON/OFF control function (Active high)
- High accuracy output voltage : ±2% (7.8 V output)
- Output current excess of 100 mA

-2% to +1% (10 V output)

- · Surface mount device package
- · On-chip all kinds of protection circuit
- : 4-pin plastic SIP (TO-126 Gullwing) (7.8 V output) 8-pin plastic SOP (225mil) (7.8 V output, 10 V output)

ORDERING INFORMATION

Part Number	Package	Output Voltage	
μPC29S78H	4-pin plastic SIP (TO-126)	7.8 V	
μ PC29S78TA	4-pin plastic SIP (TO-126 Gullwing)	7.8 V	
μ PC29S78GR	8-pin plastic SOP (225 mil)	7.8 V	
μ PC29S10GR	8-pin plastic SOP (225 mil)	10 V	

PIN CONFIGURATIONS (Marking Side)

TO-126

• μPC29S78H

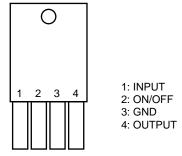
TO-126 Gullwing

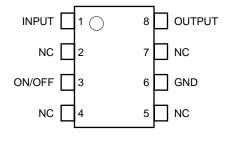
• μPC29S78TA

8-pin plastic SOP (225mil)

★ • µPC29S78GR

• μPC29S10GR





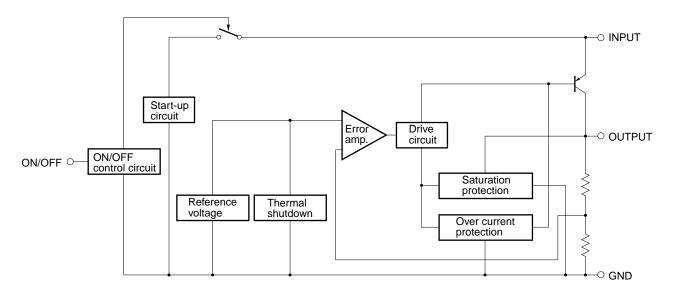
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BLOCK DIAGRAM



★ ABSOLUTE MAXIMUM RATINGS (T_A = 25°C, unless otherwise specified.)

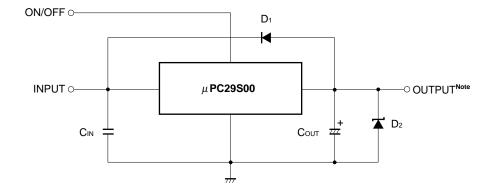
Parameter	Symbol	Rating		
Parameter	Symbol	μPC29S78H, 29S78TA	μPC29S78GR, 29S10GR	Unit
Input Voltage	Vin	2	20	
Internal Power Dissipation	ernal Power Dissipation P _T Note 1.2 0.48		W	
Operating Ambient Temperature	TA	-30 to +85		°C
Operating Junction Temperature	ΤJ	-30 to +150		°C
Storage Temperature	T _{stg}	−55 to +150		°C
Thermal Resistance (Junction to Ambient)	Rth (J-A)	104	260	°C/W

Note $T_A \le 25^{\circ}C$, Internally limited

When operating junction temperature rises up to 150°C, the internal circuit shutdown output voltage.

Caution Exposure to Absolute Maximum Ratings for extended periods may affect device reliability; exceeding the ratings could cause permanent damage. The parameters apply independently. The device should be operated within the limits specified under DC and AC Characteristics.

TYPICAL CONNECTION



C_{IN} : 0.1 to 0.47 μF. Be sure to connect to prevent abnormal oscillation. For using capacitors, film capacitors whose voltage and temperature characteristics are excellent are recommended. Take care that some monolithic ceramic capacitor is inferior in the temperature and voltage characteristics. When using the monolithic ceramic capacitor, the C_{IN} needs to be held these capacities in voltage and temperature used.

Cout : 10μ F or higher. Be sure to connect to prevent oscillation and to improve the transient load stabilization.

Remark Connect the CIN and COUT to IC pins as close as possible (2 cm or less).

D₁ : Need for V₀ > V_{IN}

D₂ : Need a shottky barrier diode for Vo < GND.

Note When output is off (VoN/OFF = low level), OUTPUT pin should not be supplied higher voltage than VIN voltage from external.

 \star Caution When using the μ PC29S78GR and μ PC29S10GR, design your circuit and mounting with consideration for heat radiation.



RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Condition	MIN.	TYP.	MAX.	Unit
Input Voltage	Vin	μPC29S78	8.8		18	٧
		μPC29S10	11		18	V
Output Current	lo		0		100	mA
Operating Ambient Temperature	TA		-30		+85	°C
Operating Junction Temperature	TJ		-30		+125	°C

Caution If the Absolute Maximum Rating is not exceeded, there is no problem for using recommended operating range or more. Use and evaluate the μ PC29S00 Series since the leeway is decreased with the Absolute Maximum Rating. Moreover, the recommended operating range is not prescribed to use when all parameters are maximum value.

ELECTRICAL CHARACTERISTICS

 μ PC29S78 (Vin = 12 V, lo = 50 mA, Von/off = 5 V, T_J = 25°C, unless otherwise specified.)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Output Voltage	Vo		7.64	7.8	7.96	V
		$8.5 \text{ V} \le \text{V}_{\text{IN}} \le 18 \text{ V},$ $0 \text{ mA} \le \text{Io} \le 50 \text{ mA},$ $0^{\circ}\text{C} \le \text{T}_{\text{J}} \le +125^{\circ}\text{C}$	7.56		8.04	
		$0 \text{ mA} \leq I_0 \leq 100 \text{ mA},$ $0^{\circ}C \leq T_J \leq +125^{\circ}C$	7.56		8.04	
Line Regulation	REGIN	8.8 V ≤ V _{IN} ≤ 18 V		22	75	mV
Load Regulation	REGL	0 mA ≤ lo ≤ 100 mA		21	75	mV
Quiescent Current	IBIAS	Io = 0 mA		3.0	5.0	mA
		lo = 100 mA		11	25	
Start-up Quiescent Current	BIAS(s)1	V _{IN} = 7.3 V, Io = 0 mA		10	20	mA
	BIAS(s)2	V _{IN} = 7.3 V, Io = 100 mA			50	mA
Quiescent Current Change	$\Delta {\sf I}$ bias	8.8 V \leq V _{IN} \leq 18 V, 0°C \leq T _J \leq +125°C			10	mA
Output Noise Voltage	Vn	10 Hz ≤ f ≤ 100 kHz		160		μVr.m.s.
Ripple Rejection	R∙R	f = 120 Hz, 8.8 V ≤ V _{IN} ≤ 13.5 V	42	51		dB
Dropout Voltage	V _{DIF}	Io = 100 mA, 0°C ≤ TJ ≤ +125°C			1.0	V
Peak Output Current	O peak	V _{IN} = 9.8 V	150	250	400	mA
Short Circuit Current	O short	V _{IN} = 18 V		250		mA
Temperature Coefficient of Output Voltage	ΔVο/ΔΤ	Io = 5 mA, 0° C \leq T _J \leq +125 $^{\circ}$ C		-0.4		mV/°C
ON/OFF Voltage	Von/off1	V _{IN} = 12 V, Io = 10 mA		1.8	2.0	V
	Von/off2	V _{IN} = 12 V, Io = 0 mA	0.8	1.6		V
ON/OFF Current	lon/off1	Von/off = 2.7 V, lo = 0 mA		250	450	μΑ
	lon/off2	Von/off = 5 V, Io = 0 mA		450	800	μΑ
Standby Current	BIAS OFF	Von/off = 0 V, Io = 0 mA			10	μΑ



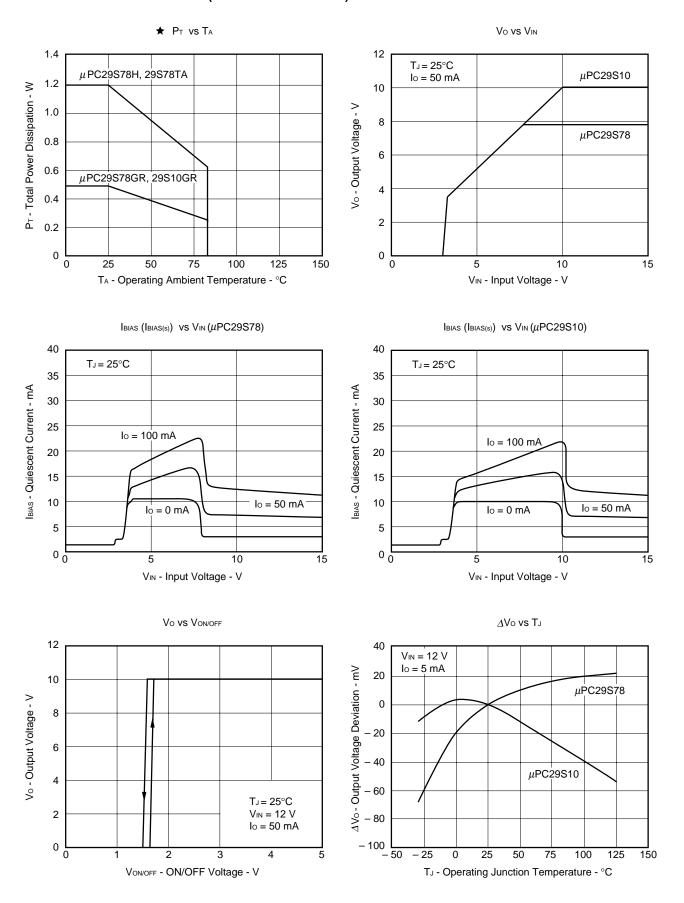
μ PC29S10 (Vin = 12 V, Io = 50 mA, Von/off = 5 V, T_J = 25°C, unless otherwise specified.)

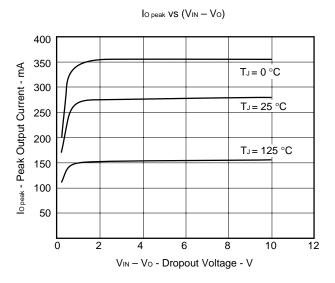
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Output Voltage	Vo		9.80	10.00	10.10	V
			9.70		10.20	
		$0 \text{ mA} \leq I_0 \leq 100 \text{ mA},$ $0^{\circ}C \leq T_J \leq +125^{\circ}C$	9.70		10.20	
Line Regulation	REGIN	11 V ≤ V _{IN} ≤ 18 V		27	100	mV
Load Regulation	REGL	0 mA ≤ lo ≤ 100 mA		18	100	mV
Quiescent Current	IBIAS	Io = 0 mA		3.3	5.0	mA
		lo = 100 mA		12	25	
Start-up Quiescent Current	BIAS(s)1	V _{IN} = 9.5 V, I _O = 0 mA		10	20	mA
	BIAS(s)2	V _{IN} = 9.5 V, I _O = 100 mA			50	mA
Quiescent Current Change	ΔI bias	11 V \leq V _{IN} \leq 18 V, 0°C \leq T _J \leq +125°C		1.0	10	mA
Output Noise Voltage	Vn	10 Hz ≤ f ≤ 100 kHz		210		μVr.m.s.
Ripple Rejection	R∙R	f = 120 Hz, 11 V ≤ V _{IN} ≤ 13.5 V	40	48		dB
Dropout Voltage	V _{DIF}	Io = 100 mA, 0°C ≤ T _J ≤ +125°C		0.4	1.0	V
Peak Output Current	lO peak	V _{IN} = 12 V	150	250	400	mA
Short Circuit Current	O short	V _{IN} = 18 V		180		mA
Temperature Coefficient of Output Voltage	ΔVο/ΔΤ	Io = 5 mA, 0°C ≤ T _J ≤ +125°C		-0.5		mV/°C
ON/OFF Voltage	Von/off1	V _{IN} = 12 V, Io = 10 mA		1.8	2.0	V
	Von/off2	V _{IN} = 12 V, I _O = 0 mA	0.8	1.6		V
ON/OFF Current	lon/off1	Von/off = 2.7 V, Io = 0 mA		250	450	μΑ
	lon/off2	Von/off = 5 V, Io = 0 mA		450	800	μΑ
Standby Current	BIAS OFF	Von/off = 0 V, lo = 0 mA			10	μΑ

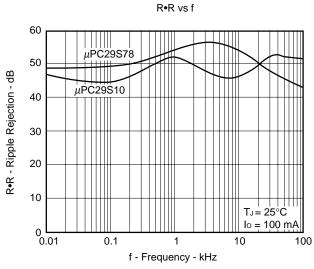
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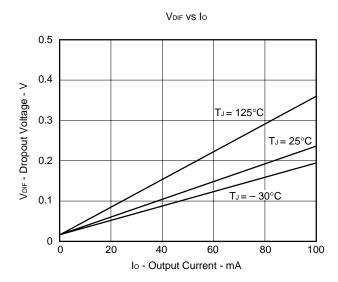


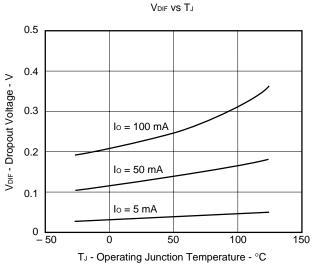
TYPICAL CHARACTERISTICS (REFERENCE VALUES)





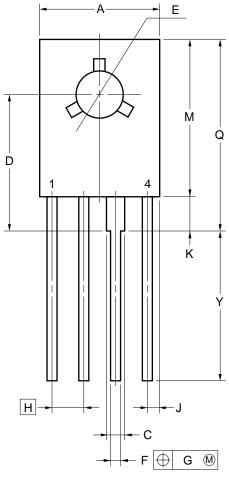


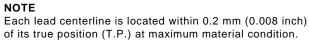


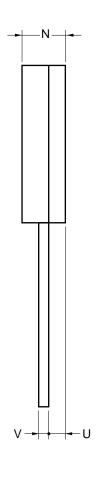


PACKAGE DRAWINGS

4 PIN PLASTIC SIP (TO-126)



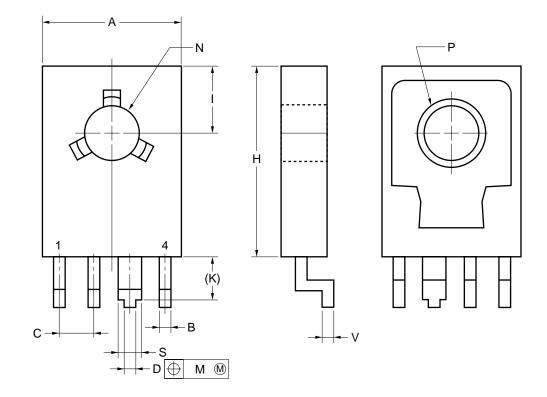


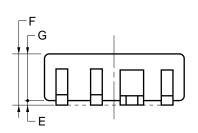


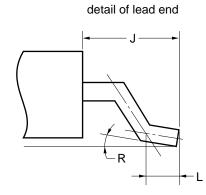
ITEM	MILLIMETERS	INCHES
Α	8.5 MAX.	0.335 MAX.
С	1.1 MIN.	0.043 MIN.
D	9.7±0.3	0.382±0.012
Е	φ3.2±0.1	φ0.126±0.004
F	0.65±0.1	$0.026^{+0.004}_{-0.005}$
G	0.2	0.008
Н	2.0	0.079
J	1.25 MAX.	0.05 MAX.
K	2.3 MIN.	0.09 MIN.
М	11.5 MAX.	0.453 MAX.
N	2.7±0.2	0.106 +0.009 -0.008
Q	14.5 MAX.	0.571 MAX.
U	1.7 MAX.	0.067 MAX.
V	0.55±0.1	0.022 +0.004 -0.005
Υ	13.5±0.7	0.531 +0.029 -0.028

P4HP-200B-1

4 PIN PLASTIC SIP (TO-126 GULLWING)

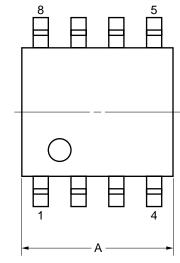




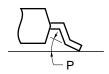


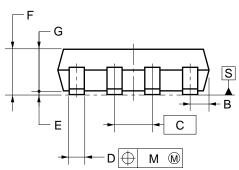
ITEM	MILLIMETERS
Α	8.0±0.2
В	0.65±0.1
С	2.0±0.3
D	0.65±0.1
E	0.25±0.15
F	3.2 MAX.
G	2.7±0.1
Н	11.0±0.2
ı	3.8
J	3.0±0.5
K	2.5
L	1.3±0.3
М	0.18
N	3.2±0.1
Р	ϕ 4.0
R	3°+5°
S	1.25±0.1
V	0.55±0.1

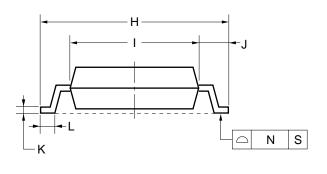
8 PIN PLASTIC SOP (225 mil)



detail of lead end







NOTE

Each lead centerline is located within 0.12 mm of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS
Α	$5.2^{+0.17}_{-0.20}$
В	0.78 MAX.
С	1.27 (T.P.)
D	$0.42^{+0.08}_{-0.07}$
E	0.1±0.1
F	1.59±0.21
G	1.49
Н	6.5±0.3
I	4.4±0.15
J	1.1±0.2
K	$0.17^{+0.08}_{-0.07}$
L	0.6±0.2
М	0.12
N	0.10
Р	3°+7°

S8GM-50-225B-5



RECOMMENDED SOLDERING CONDITIONS

When soldering these products, it is highly recommended to observe the conditions as shown below. If other soldering processes are used, or if the soldering is performed under different conditions, please make sure to consult with our sales offices.

For more details, refer to our document "SEMICONDUCTOR DEVICE MOUNTING TECHNOLOGY MANUAL" (C10535E).

Surface mount devices

 μ PC29S78TA: 4-pin plastic SIP (TO-126 Gullwing)

Process	Conditions	Symbol
Infrared ray reflow	Peak temperature: 235°C or below (Package surface temperature), Reflow time: 30 seconds or less (at 210°C or higher), Maximum number of reflow processes: 2 times.	IR35-00-2
VPS	Peak temperature: 215°C or below (Package surface temperature), Reflow time: 40 seconds or less (at 200°C or higher), Maximum number of reflow processes: 2 times.	VP15-00-2
Wave soldering	Solder temperature: 260°C or below, Flow time: 10 seconds or less, Maximum number of flow processes: 1 time, Pre-heating temperature: 120°C or below (Package surface temperature).	WS60-00-1
Partial heating method	Pin temperature: 300°C or below, Heat time: 3 seconds or less (Per each side of the device).	-

Caution Apply only one kind of soldering condition to a device, except for "partial heating method", or the device will be damaged by heat stress.

\star µPC29S78GR, 29S10GR: 8-pin plastic SOP (225 mil)

Process	Conditions	Symbol
Infrared ray reflow	Peak temperature: 235°C or below (Package surface temperature), Reflow time: 30 seconds or less (at 210°C or higher), Maximum number of reflow processes: 3 times.	IR35-00-3
VPS	Peak temperature: 215°C or below (Package surface temperature), Reflow time: 40 seconds or less (at 200°C or higher), Maximum number of reflow processes: 3 times.	VP15-00-3
Wave soldering	Solder temperature: 260°C or below, Flow time: 10 seconds or less, Maximum number of flow processes: 1 time, Pre-heating temperature: 120°C or below (Package surface temperature).	WS60-00-1
Partial heating method	Pin temperature: 300°C or below, Heat time: 3 seconds or less (Per each side of the device).	-

Caution Apply only one kind of soldering condition to a device, except for "partial heating method", or the device will be damaged by heat stress.



Through-hole device

μ PC29S78H: 4-pin plastic SIP (TO-126)

Process	Conditions
Wave soldering (only to leads)	Solder temperature: 260°C or below, Flow time: 10 seconds or less.
Partial heating method	Pin temperature: 300°C or below, Heat time: 3 seconds or less (per each lead).

Caution For through-hole device, the wave soldering process must be applied only to leads, and make sure that the package body does not get jet soldered.

CAUTION ON USE

When using the μ PC29S00 series at the input voltage which is lower than in the recommended operating condition, the big quiescent current flows through device because the transistor of the output paragraph is saturated (Refer to IBIAS (IBIAS (s)) VIN curves in **TYPICAL CHARACTERISTICS**). The μ PC29S00 series has saturation protection circuits, but they sometimes need about 50 mA current. Therefore the power supply on the input needs the enough current capacity to pass this quiescent current when the device start-up.

REFERENCE DOCUMENTS

QUALITY GRADES ON NEC SEMICONDUCTOR DEVICES	C11531E
SEMICONDUCTOR DEVICE MOUNTING TECHNOLOGY MANUAL	C10535E
SEMICONDUCTORS SELECTION GUIDE	X10679E

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- While NEC Corporation has been making continuous effort to enhance the reliability of its semiconductor devices, the possibility of defects cannot be eliminated entirely. To minimize risks of damage or injury to persons or property arising from a defect in an NEC semiconductor device, customers must incorporate sufficient safety measures in its design, such as redundancy, fire-containment, and anti-failure features.
- NEC devices are classified into the following three quality grades:
 - "Standard", "Special", and "Specific". The Specific quality grade applies only to devices developed based on a customer designated "quality assurance program" for a specific application. The recommended applications of a device depend on its quality grade, as indicated below. Customers must check the quality grade of each device before using it in a particular application.
 - Standard: Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots
 - Special: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)
 - Specific: Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

The quality grade of NEC devices is "Standard" unless otherwise specified in NEC's Data Sheets or Data Books. If customers intend to use NEC devices for applications other than those specified for Standard quality grade, they should contact an NEC sales representative in advance.

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